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The influence of carbon on the adsorption/desorption kinetics and monolayer formation of *p*-quaterphenyl on Au(111)

S. Müllegger*, A. Winkler

Institute of Solid State Physics, Graz University of Technology, Petersgasse 16, A-8010 Graz, Austria

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Abstract

The influence of surface carbon on the formation of highly regular thin films of *p*-quaterphenyl (4P) grown on a Au(111) surface has been investigated in the mono- and multilayer regime by thermal desorption spectroscopy (TDS), X-ray photoelectron spectroscopy (XPS) and micro-channelplate low energy electron diffraction (MCP-LEED) under UHV conditions. A small carbon pre-coverage of 0.03 monolayers (ML) improves the surface mobility of adsorbed 4P molecules with respect to the clean surface by passivating Au surface defects. This enables a highly crystalline 4P film growth even at a low substrate temperature of 93 K. Otherwise, the thermodynamically stable monolayer structure is identical to that on the C-free surface, namely consisting of alternating edge/face packed, lying molecules. The structure of the first 4P monolayer grown on a 0.15 ML C covered Au(111) surface is different. Only edge-on oriented molecules accommodate in the corresponding surface unit cell. At a C coverage of 0.5 ML the first 4P monolayer is disordered, whereas for higher coverages a highly crystalline structure with upright standing molecules is adopted. Depending on the substrate temperature during film growth the surface carbon causes a different wetting behaviour of the 4P films, resulting in a different mesoscopic film morphology.

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Keywords: Thermal desorption spectroscopy; Low energy electron diffraction (LEED); Adsorption kinetics; Quaterphenyl; Gold; Carbon, Surface structure, morphology, roughness, and topography

1. Introduction

Thin films (<1 μm) of conjugated organic materials prepared by vacuum-deposition techniques are still attracting both academic and technical

* Corresponding author. Tel.: +43 316 873 8967; fax.: +43 316 873 8466.

E-mail address: stefan.muellegger@tugraz.at (S. Müllegger).

30 interest. The application of such materials in or-
31 ganic (opto)electronic devices has been frequently
32 demonstrated [1–3]. It has been shown, that the
33 film structure strongly influences properties rele-
34 vant for device fabrication, e.g. the charge carrier
35 mobility [4]. In order to optimize such properties,
36 the preparation of well-defined, highly crystalline
37 organic films is of great importance [5,6]. A com-
38 monly used tool for the preparation of tailored
39 organic thin films is the variation of fabrica-
40 tion parameters during film growth, such as the
41 adsorption rate, substrate temperature, -geometry
42 and -chemistry [7–10]. The latter can easily be
43 influenced by applying an adequate adsorbate
44 layer to the original substrate prior to the organic
45 film deposition.

46 The present study focuses on the model system
47 *p*-quaterphenyl (4P, C₂₄H₁₈) grown on a single
48 crystalline Au(111) substrate. Several surface
49 analytical methods have been applied such as
50 thermal desorption spectroscopy (TDS), X-ray
51 photoelectron spectroscopy (XPS), Auger electron
52 spectroscopy (AES) and micro-channelplate low
53 energy electron diffraction (MCP-LEED). The
54 influence of a changed substrate chemistry on
55 the adsorption/desorption kinetics and growth of
56 4P thin films has been investigated in the mono-
57 layer (ML) and multilayer coverage regime. The
58 substrate chemistry has been varied by preparing
59 different carbon pre-coverages on the Au(111)
60 substrate prior to the 4P film deposition. It has
61 been demonstrated that the film morphology
62 and in particular the structure of the interfacing
63 first 4 P monolayer can be tailored by applying
64 different C pre-coverages. Similar to previous
65 findings of 4 P grown on a C-free Au(111) sur-
66 face [11,12], the regular first 4P monolayer has
67 been shown to act as a structural pre-stage for
68 the following multilayer growth [13]. To the best
69 knowledge of the authors no comparable investi-
70 gation on the influence of surface carbon on the
71 organic thin film growth is available in the litera-
72 ture so far. It should be emphasised that the tai-
73 loring of the metal/organic interface by surface
74 carbon may have a considerable relevance for
75 the fabrication of optimised contact electrode
76 interfaces.

2. Experimental

78 All experiments were performed in an ultra-
79 high vacuum system at a base pressure of about
80 10⁻¹⁰ mbar. A high-purity Au(111) single crystal
81 was cleaned by Ar⁺ ion sputtering (5 × 10⁻⁵ mbar,
82 1 keV) and annealed at 870 K. After the cleaning
83 procedure the Au surface was covered by different
84 amounts of carbon. These C-covered Au(111) sur-
85 faces were used as substrates for the 4P thin film
86 deposition. In particular, 4P films grown on three
87 different C-covered Au(111) substrates were inves-
88 tigated: 0.03 ML C/Au(111), 0.15 ML C/Au(111)
89 and 0.5 ML C/Au(111). The carbon coverages,
90 which were determined by quantitative Auger
91 spectroscopy, were established by either one of
92 the following methods: (1) 4P dissociation during
93 sample heating: Auger analysis reveals that after
94 a few ML of 4P are adsorbed and thermally des-
95 orbed on/from a thoroughly cleaned and annealed
96 Au(111) surface, small amounts of C remain on
97 the surface. The origin of this C coverage is attrib-
98 uted to the dissociation of 4P molecules pinned to
99 surface defects on the Au(111) surface. The C
100 atoms partially passivate these defects and after
101 applying several consecutive 4P adsorption/
102 desorption cycles, in our case the C-coverage levels
103 off at about 0.03 ML. This corresponds to a com-
104 plete passivation of the Au surface defects. (2) Car-
105 bon coverages greater than 0.03 ML were prepared
106 by means of X-ray induced dissociation of 4P mol-
107 ecules previously adsorbed on the Au surface: A
108 5 nm thick 4P film grown at 93 K on Au(111)
109 was exposed to the MgK_α radiation of our XPS
110 instrument for 30 and 90 min, respectively. Hereaf-
111 ter, the remaining intact 4P molecules were ther-
112 mally desorbed by heating the sample up to
113 870 K. C-coverages of 0.15 and 0.50 ML were pre-
114 pared in this way.

115 Thin films of 4P were evaporated onto the dif-
116 ferently C-covered Au substrates from a home-
117 made quartz glass Knudsen cell. The substrate
118 temperature was 93 and 300 K, respectively, and
119 the deposition rate was 1 ML/min. The total
120 amount of 4P molecules adsorbed on the Au sub-
121 strate was quantitatively measured in-situ during
122 the deposition process by a quartz micro balance,
123 as described in Ref. [14]. The desorption kinetics

124 was investigated by TDS using an in-line quadrupole mass spectrometer (linear heating rate: 1 K/s, detected mass: 306 amu). Combined XPS and TDS experiments were performed for investigating structural changes of the 4P film upon sample heating prior to desorption. These measurements are denoted by “XPS vs. Temp”—measurements and details on this technique can be found in Ref. [14]. MCP-LEED experiments were performed at 93 K, applying very small electron beam currents (a few nA) and the positions of the diffraction spots were corrected for inherent image deformations caused by the LEED optics.

137 3. Results

138 3.1. Adsorption/desorption kinetics

139 The TDS results of 4P grown on a 0.03 ML C/Au(111) surface at 93 K are shown in Fig. 1a. To begin with the low coverage regime (curves a–d), the first desorption peak, labelled β_1 , appears above 550 K. With increasing coverage the peak maximum shifts to lower temperatures until β_1 is saturated at a mean film thickness of about 0.15 nm. At even higher coverages a second peak, labelled β_2 , appears around 380 K which saturates at about 0.3 nm (curve d). Both peaks β_1 and β_2 seem to comprise roughly the same amount of 4P molecules/cm². Since the adsorbed 4P molecules desorb intact from the 0.03 ML C/Au(111) surface these peaks are attributed to first-order desorption from the 4P monolayer. The shift of the peak maxima of both peaks to the low temperature side with increasing coverage indicates repulsive forces acting between neighbouring molecules within the monolayer [15]. At 4P coverages that exceed the saturation coverage of the first monolayer of 0.3 nm, a sharp desorption peak, labelled α , is observed that steadily increases with increasing coverage (see insert of Fig. 1a). Peak α is attributed to zero-order desorption from the multilayer. These TDS results are very similar to those obtained for 4P grown on a C-free Au(111) surface [12].

166 The 4P desorption kinetics in the monolayer regime is significantly different on the 0.15 ML C/Au(111)

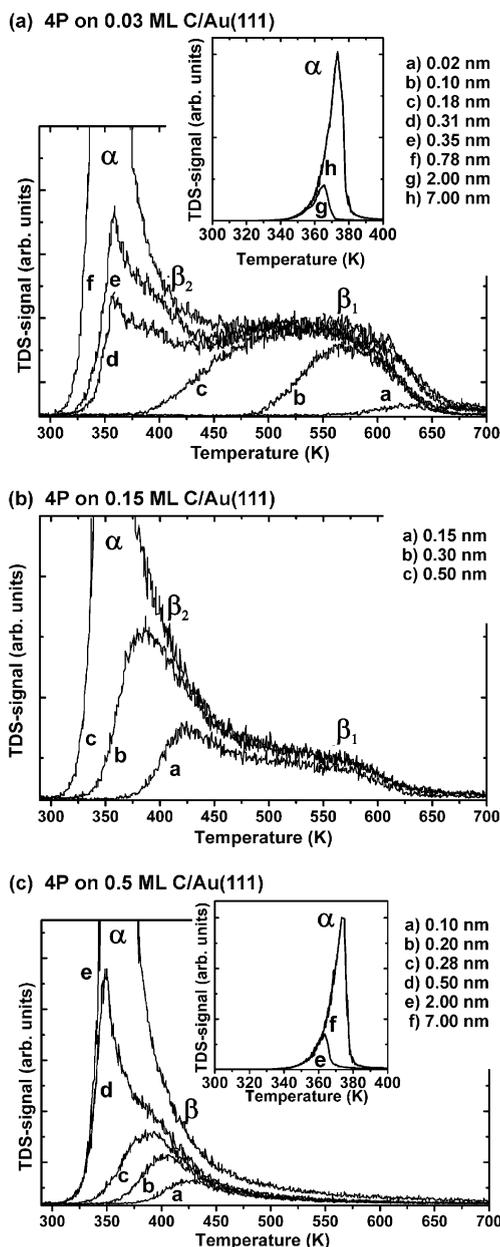


Fig. 1. Series of TD spectra of 4P grown on variably C covered Au(111) surfaces at 93 K. The monolayer and multilayer desorption peaks are denoted by β and α , respectively. The total amount of deposited 4P for each single TD spectrum is represented as the mean film thickness in nm. (a) TDS-series of 4P on 0.03 ML C/Au(111). Insert: large scale view at high coverages. On this scale, the monolayer desorption peaks are hardly visible. (b) TDS series of 4P on 0.15 ML C/Au(111). (c) TDS series of 4P on 0.5 ML C/Au(111). Insert: large scale view at high coverages.

Au(111) surface. The corresponding TDS series for 4P grown at 93 K is shown in Fig. 1b. Similar to the previous case, two monolayer desorption peaks, labelled β_1 and β_2 , are observed. Although the peaks appear in the same temperature regime as on the 0.03 ML C/Au surface, their saturation coverages are changed. The high temperature monolayer peak, β_1 , is significantly decreased in favour of an enhanced β_2 peak, yielding a ratio of $\beta_2:\beta_1 \approx 3:1$. The saturation coverage of the full 4P monolayer, $\beta_1 + \beta_2$, however, is roughly the same as in the previous case. Again, the 4PML saturates at about 0.3 nm of mean film thickness, which equals 8×10^{13} 4P molecules/cm².

The decrease of the β_1 peak with an increasing C pre-coverage of the Au(111) surface is even more pronounced on the 0.5 ML C/Au(111) surface. The corresponding TDS series is presented in Fig. 1c. At low coverages only a single desorption peak, β , arises in the temperature range between 350 and 450 K, similar to the β_2 peak found for the less C covered surfaces. No second, high temperature 4P monolayer desorption peak exists on the 0.5 ML C/Au surface. But again, the total coverage of the β peak corresponds to a mean 4P film thickness of 0.3 nm. Similar findings were made on a C-covered polycrystalline Au surface [14].

Whereas the desorption kinetics of the 4P monolayer strongly depends on the C pre-coverage, the multilayer desorption regime, α , remains nearly unchanged. Its onset occurs at about 310 K. Independent of the degree of C coverage, the α peaks exhibit a common leading edge, characteristic of zero-order desorption. According to the Polanyi-Wigner formalism a 4P multilayer desorption energy of $E_{\text{des}} = 1.47$ eV was calculated [16]. This is in good agreement to the literature value of 1.62 eV for the 4P sublimation enthalpy [17].

3.2. Multilayer growth kinetics

The growth kinetics of 4P films grown on differently C covered Au(111) surfaces at different substrate temperatures was investigated with XPS vs. temp. measurements. Fig. 2 shows the temperature dependence of the Au 4f_{7/2} signal for four inde-

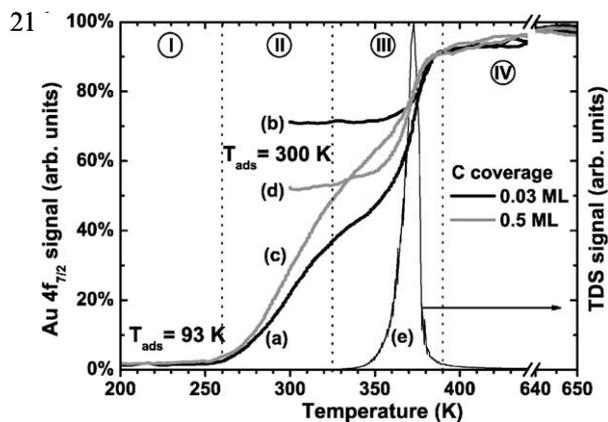


Fig. 2. (a–d) Temperature dependent XPS (Au 4f_{7/2}) measurement and (e) TDS measurement of 7 nm thick 4P films grown on variably C covered Au(111) surfaces at 93 and 300 K, respectively. The adsorption temperature and C pre-coverage of the Au(111) substrate during the 4P film deposition are (a) 93 K, 0.03 ML C, (b) 300 K, 0.03 ML C, (c) 93 K, 0.5 ML C and (d) 300 K, 0.5 ML C. The temperature range is divided into four regimes, labelled I–IV (see text).

pendently prepared 7 nm thick 4P films grown on 0.03 ML C/Au(111) and 0.5 ML C/Au(111) surfaces, respectively. The adsorption temperatures were 93 K for the curves (a) and (c) and 300 K for the curves (b) and (d), respectively. In addition, TD spectra were recorded for equivalently prepared 4P films in order to distinguish between a possible recrystallisation and 4P desorption. As the 4P multilayer TD spectra did not change significantly upon a variation of substrate chemistry or temperature, only one representative spectrum is shown (Fig. 2, curve (e)).

The investigated temperature range can be divided into four regimes according to the degree of structural and/or coverage change of the 4P films. First, the case of adsorption at 93 K is described (curves (a) and (c)). Regime I (<260 K) shows neither a structural change (XPS signal) nor a coverage change (TDS signal). In regime II (260–325 K) the films (a) and (c) show a large change in the Au 4f_{7/2} signal. This is attributed to a structural change (recrystallisation) within the 4P films, since no 4P desorption occurs in this temperature regime. The increasing Au signal indicates the formation of 4P islands, which are

286 becoming higher and at the same time lateraly
 287 smaller with increasing temperature, hence uncov-
 288 ering larger areas of the Au substrate. Within the
 289 temperature regime III (325–380 K) the 4P multi-
 290 layer desorbs, which results in a further increase
 291 of the Au signal to about 90%. Finally, the regime
 292 IV (>380 K) covers the 4P monolayer desorption,
 293 where a slight and nearly linear increase of the
 294 XPS signal can be seen until it reaches 100% of
 295 the clean Au surface at about 650 K. In the case
 296 of adsorption at 300 K, both curves (b) and (d) ex-
 297 hibit a significantly higher XPS signal than in the
 298 previous case, after heating to the same tempera-
 299 ture. Moreover, they show nearly no change of
 300 the XPS signal in regime II, whereas the qualita-
 301 tive trend within the regimes III and IV is similar
 302 to the former case.

303 3.3. Monolayer structure of 4P on 0.03 ML 304 C/Au(111)

305 Fig. 3 shows two examples of LEED images ob-
 306 tained for a 0.5 ML (a) and 1 ML (b) thick 4P film
 307 recorded at 93 K. The substrate temperature dur-
 308 ing the film growth was also 93 K. Apparently,
 309 4P forms highly regular (sub)monolayer structures
 310 on a 0.03 ML C/Au(111) surface already at low
 311 substrate temperatures. The obtained structures
 312 are identical to those found for 4P grown on a
 313 C-free Au(111) surface, as described in Refs.
 314 [11,12]. However, in that case the formation of a
 315 regular structure takes place only at room temper-
 316 ature, but not at 93 K.

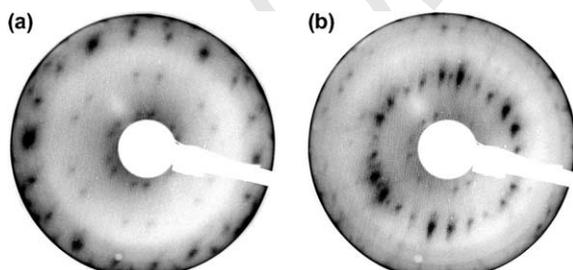


Fig. 3. LEED images recorded for (a) 0.5 ML 4P and (b) 1 ML 4P grown on a 0.03 ML C/Au(111) surface at 93 K. The corresponding beam voltages are 19.2 and 18.7 V, respectively.

317 3.4. Monolayer structure of 4P on 0.15 ML 318 C/Au(111)

319 Fig. 4 illustrates the LEED results of the 4P
 320 monolayer grown on a 0.15 ML C/Au(111) sur-
 321 face at 300 K and recorded at 93 K. The same
 322 LEED patterns have also been observed for 4P
 323 films grown at 93 K, but with inferior quality. A
 324 deformation free representation of the LEED pat-
 325 tern was gained from extracting the spot positions
 326 and is shown in Fig. 4c. The dimensions of the cor-
 327 responding 4P real space surface unit cell are in
 328 absolute values: $a = 1.05$ nm, $b = 2.21$ nm, $\gamma = 71^\circ$
 329 and $\Phi = 11^\circ$, where a and b denote the lengths of
 330

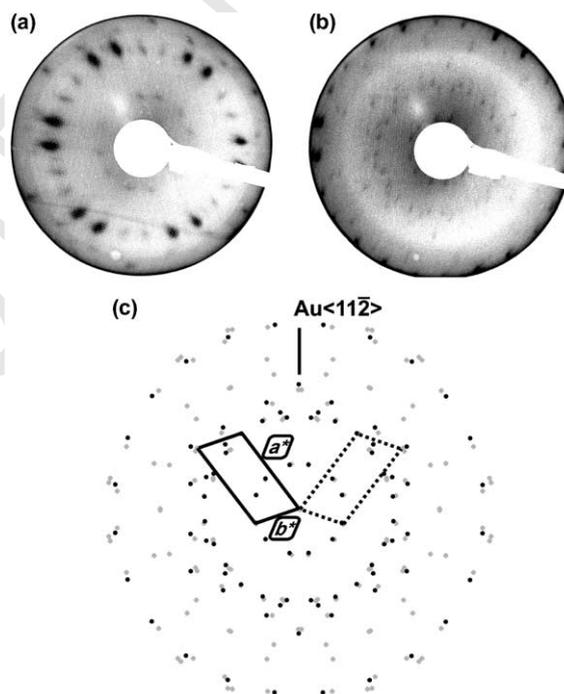


Fig. 4. LEED images of 1 ML 4P grown on a 0.15 ML C/Au(111) surface at 300 K, recorded at (a) 12.1 V and (b) 24.3 V. (c) Representation of the corresponding LEED pattern free of image deformations. Black dots correspond to experimental data, grey dots represent the simulated pattern. The reciprocal surface unit cell is indicated by a solid parallelogram and the reciprocal unit cell vectors are denoted by a^* and b^* , respectively. The dotted parallelogram represents a mirror equivalent of the reciprocal unit cell. The Au(11 $\bar{2}$) direction relative to the LEED pattern is indicated by a short line.

331 the real space unit cell vectors, γ is the cell angle
 332 and ϕ is the azimuthal rotation angle of the cell
 333 relative to the Au $\langle 1\bar{1}0 \rangle$ direction. The matrix rep-
 334 resentation of this superstructure is

$$M = \begin{pmatrix} 4.09 & 0.83 \\ 5.61 & 9.03 \end{pmatrix} \approx \begin{pmatrix} 4 & 1 \\ 5.5 & 9 \end{pmatrix}. \quad (1)$$

337 3.5. Monolayer structure of 4P on 0.5 ML C/Au(111)

338 The 0.5ML C/Au(111) surface exhibits the
 339 same LEED pattern as a C-free Au(111) surface.
 340 No extra spots were observed that could be attrib-
 341 uted to a regular carbon superstructure. After the
 342 deposition of 1ML 4P at 93K or 300K, no addi-
 343 tional LEED spots could be observed, suggesting
 344 that 4P cannot form a regular monolayer structure
 345 on the 0.5ML C/Au(111) surface. Instead, the 4P
 346 monolayer (wetting layer) seems to be amorphous.
 347 However, after increasing the 4P coverage, ring-
 348 like structures appear in LEED already at a nom-
 349 inal thickness of 0.6nm and can be observed up to
 350 a mean film thickness of several nm. Fig. 5 shows
 351 two examples of LEED images at different beam
 352 voltages recorded for a 3nm thick 4P film grown
 353 at 300K. The origin of these rings is attributed
 354 to the existence of highly ordered 4P domains with
 355 an arbitrary azimuthal orientation. The lateral size
 356 of these regular 4P domains can be up to 700nm,
 357 as observed in recent AFM experiments on a
 358 30nm thick 4P film grown on 0.5ML C covered

Au(111) [18]. A more detailed analysis of this
 structure is given below.

4. Discussion

362 Before the influence of surface carbon on the 4P
 363 layer growth is discussed, we will briefly recapitu-
 364 late the major results recently found for 4P grown
 365 on C-free Au(111) [11,12]. A regular 4P mono-
 366 layer structure is established only above 270K.
 367 The monolayer comprises two molecules per sur-
 368 face unit cell being oriented with their long molec-
 369 ular axes parallel to the Au surface. The aromatic
 370 planes of the molecules are oriented either nearly
 371 parallel or side-tilted with respect to the surface
 372 (edge-face packing). This overlayer packing is cor-
 373 roborated by TDS results exhibiting two distinct
 374 monolayer desorption peaks [12]. The 4P mono-
 375 layer saturates at about 0.3nm of nominal film
 376 thickness.

377 As far as the desorption kinetics of 4P is con-
 378 cerned, an additional 0.03ML C pre-coverage of
 379 the Au(111) surface has no significant influence.
 380 The experimental results are similar to previous
 381 findings for 4P grown on a C-free Au(111) sur-
 382 face. However, the surface mobility of the 4P mol-
 383 ecules is considerably enhanced. This can be
 384 deduced from the appearance of a regular 4P
 385 LEED pattern already at a low monolayer growth
 386 temperature of 93K. Apparently, surface defects
 387 on the sputter cleaned and annealed Au(111) sur-
 388 face act as pinning centers for 4P surface diffusion.
 389 These defects can either be vacancies, adatoms,
 390 kinks, steps or reconstruction “elbows” of the
 391 reconstructed Au(111) surface. However, a spe-
 392 cific determination of the type of defects was not
 393 possible with the applied methods. Small amounts
 394 of C can deactivate these defects, which results in a
 395 higher mobility of the 4P molecules. Indeed, such
 396 small amounts of C stem from dissociation of ad-
 397 sorbed 4P molecules during sample heating. Those
 398 4P molecules pinned to surface defects are no long-
 399 er able to desorb intact from the surface and thus
 400 do not contribute to the TD spectrum. In the case
 401 of 4P grown on C-free Au(111), a detailed analysis
 402 of the TD peak areas shows that a maximum
 403 amount of 2×10^{12} 4P molecules/cm² is constantly

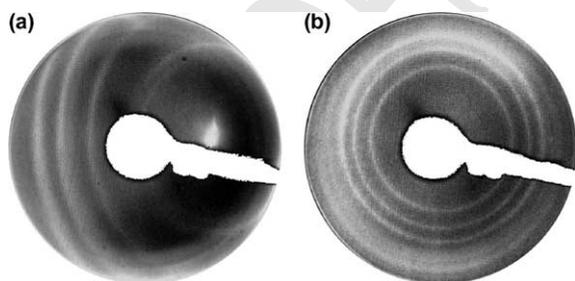


Fig. 5. LEED images of a 3nm 4P film grown on a 0.5ML C/Au(111) surface at 300K. (a) was recorded at 16.6V with a non-normal incident beam. The specular reflection is clearly visible on the right. (b) was recorded at 52.1V with normal incidence.

404 missing in the TD spectra. This amount corre-
 405 sponds to pinned 4P molecules that dissociate dur-
 406 ing sample heating. Hence, a C-coverage of about
 407 5×10^{13} atoms/cm² remains on the formerly C-free
 408 Au(111) surface (surface density of Au(111):
 409 1.4×10^{15} atoms/cm²). This finding is in good
 410 agreement with the coverage of 0.03 ML C ob-
 411 tained by a quantitative Auger analysis after sev-
 412 eral 4P adsorption/desorption cycles without
 413 intermediate sputter cleaning of the surface, as de-
 414 scribed above. Apart from a different 4P surface
 415 mobility, LEED measurements show that on both
 416 the C-free Au(111) surface and the 0.03 ML C/
 417 Au(111) surface the structure of the 4P monolayer
 418 is identical. In that sense, the 0.03 ML C/Au(111)
 419 surface could as well be regarded as a “defect-free”
 420 Au(111) surface, where all pinning sites are passi-
 421 vated by C atoms and no longer hinder 4P surface
 422 diffusion.

423 Increasing the C pre-coverage to 0.15 ML in-
 424 duces a change of the 4P monolayer structure:
 425 the LEED results (see Fig. 4) show a slight change
 426 of the dimensions of the 4P monolayer unit cell.
 427 Whereas the lengths of the cell vectors, a and b ,
 428 and the cell angle, γ , are only slightly changed
 429 compared to 4P grown on a C-free Au(111) sur-
 430 face, the azimuthal angle, ϕ , is significantly differ-
 431 ent. This indicates a new 4P structure. Although
 432 from the LEED experiments no proper information
 433 on the molecular packing within the 4P mono-
 434 layer surface unit cell can be derived, a
 435 combination of the LEED and TDS data allows
 436 a further insight: the TDS monolayer spectrum
 437 can be interpreted by a superposition of two differ-
 438 ent types of 4P monolayer packing domains, de-
 439 noted “type A” and “type B”. The type A
 440 domains exhibit both flat and edge-on adsorbed
 441 4P molecules (edge-face packing) similar to the
 442 structure found on the C-free Au(111) surface.
 443 The flat/edge-on adsorbed molecules contribute
 444 in equal shares to the β_1 and β_2 peak, respectively.
 445 Consequently, the β_2 peak in Fig. 1b, which corre-
 446 spond to edge-on adsorbed molecules, is attributed
 447 to a superposition of two peaks, i.e. $\beta_2 = \beta_{2,A} +$
 448 $\beta_{2,B}$. The $\beta_{2,B}$ peak is attributed to the type B pack-
 449 ing domains, which comprise only edge-on ori-
 450 ented 4P molecules. Apparently, this type of 4P
 451 domain is by far the dominating one. This is cor-

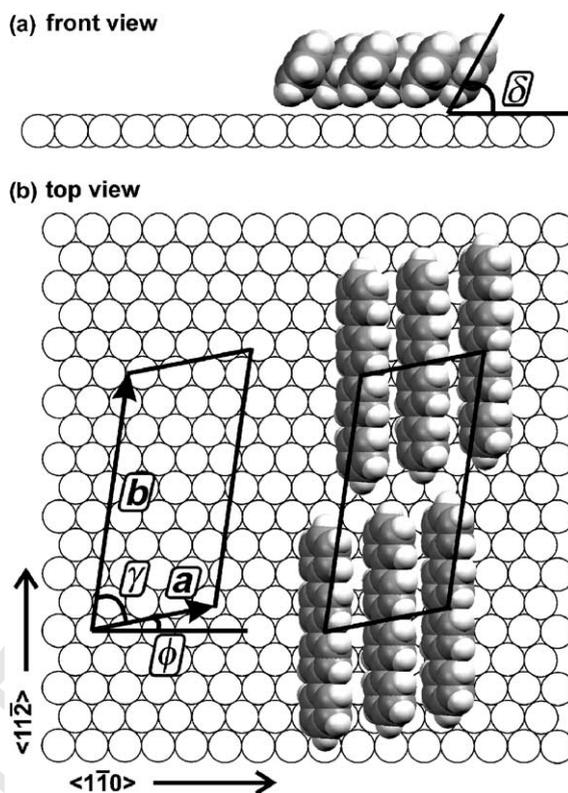


Fig. 6. Real space van der Waals representation of the 4P monolayer structure on a 0.15 ML C/Au(111) surface. The surface unit cell is characterised by the lengths of the unit cell vectors, a and b , the cell angle, γ , and the azimuthal angle, ϕ . The aromatic planes of the 4P molecules are side-tilted with respect to the Au(111) plane by an angle δ .

452 corroborated by the LEED images shown in Fig. 4, 453
 454 where all observed diffraction spots could be attributed to the type B domains. A real space representation of the type B domain structure is shown in Fig. 6. The long molecular axes are oriented nearly parallel to the surface with the aromatic plane being tilted by an angle δ with respect to the Au(111) plane (edge-on), as shown in Fig. 6a. Of course, no information on the tilt angle can be obtained from our experimental techniques. An alignment of the 4P molecules along the Au(112) azimuthal direction similar to previous findings on a C-free Au(111) surface [11] has been proposed. As will be described in a forthcoming paper [13], the dominant type B domain structure typical for the 4P monolayer grown on a 467

468 0.15 ML C/Au(1 1 1) surface causes thicker 4P films
469 to adopt a crystal orientation with a similar molec-
470 ular packing structure.

471 On the 0.5 ML C/Au(1 1 1) the saturation cover-
472 age of the full 4P monolayer, β , is again about
473 0.3 nm, similar to the less C covered Au surfaces.
474 This suggests that the 4P monolayer again consists
475 of lying molecules, i.e. the long molecular axes are
476 almost parallel to the Au(111) plane. From the
477 obvious similarity of the shape and position of
478 the β_2 peak on the C-free surface and the β peak
479 on the 0.5 ML C/Au surface, it seems plausible to
480 attribute the peak β to an edge-on adsorption
481 geometry, similar to the former case. The total
482 suppression of the β_1 peak suggests a 4P mono-
483 layer exhibiting exclusively edge-on adsorbed mol-
484 ecules. However, the LEED results show that the
485 first 4P monolayer predominantly grows in a dis-
486 ordered manner on the 0.5 ML C/Au(1 1 1) surface.
487 After the first monolayer is saturated, however,
488 with increasing coverage regular 4P domains start
489 to grow. These domains no longer show any pref-
490 erential azimuthal orientation relative to the C/
491 Au(1 1 1) surface. Hence, ring-like LEED struc-
492 tures are observed, as shown in Fig. 5. Although
493 no complete determination of the corresponding
494 real space surface unit cell is possible, an analysis
495 of the inmost ring observable with LEED at a min-
496 imum beam voltage allows a further insight: This
497 particular ring corresponds to the length, b , of
498 the largest possible real space surface unit cell vec-
499 tor of a regular 4P overlayer structure. Assuming a
500 rectangular surface unit cell for a first approxima-
501 tion, a length of $b = 1.1$ nm is obtained. This is sig-
502 nificantly smaller than the van der Waals length of
503 a 4P molecule. Therefore, the regular 4P domains
504 responsible for the ring-like LEED structures can-
505 not comprise lying 4P molecules, as found for the
506 less C-covered surfaces. Instead, the 4P molecules
507 are supposed to be nearly “standing upright” with
508 respect to the C/Au surface, i.e. the long molecular
509 axes are oriented roughly normal to the Au(1 1 1)
510 plane. These findings are corroborated by prelimi-
511 nary results from X-ray diffraction experiments for
512 a 30 nm thick 4P film grown on 0.5 ML C/
513 Au(1 1 1), where an upright molecular orientation
514 was found within 4P crystallites in the bulk phase
515 [13]. On a 0.5 ML C/Au(1 1 1) surface the first reg-

ular 4P monolayer acts as a structural pre-stage 516
for the further epitaxial growth of thicker 4P films 517
again, similar to the findings on less C-covered Au 518
surfaces. 519

So far it has been shown that the existence of a 520
C pre-coverage influences the structure of the first 521
4P monolayer. Additionally, the particular mono- 522
layer structure influences the mesoscopic film mor- 523
phology of several nm thick 4P films, as inferred 524
from the combined XPS/TDS measurements 525
shown in Fig. 2. Here, the influence of the adsorp- 526
tion temperature and/or the carbon pre-coverage 527
on the 4P film morphology can be separately ana- 528
lyzed by comparing the corresponding curves: (1) 529
Adsorption temperature: Both films grown at 530
room temperature, (b) and (d), exhibit a signifi- 531
cantly large Au signal at 300 K. The signals remain 532
nearly unchanged upon a further heat treatment 533
until desorption sets in. Hence, independent of 534
the amount of C pre-coverage, a thermodynamically 535
stable 4P island morphology is achieved al- 536
ready at 300 K. This is due to a high surface 537
mobility of the 4P molecules in the multilayer. 538
The 4P islands are highly crystalline, as determined 539
by recent X-ray diffraction measurements [11]. In 540
contrast to that, the surface diffusion is hindered 541
at 93 K, resulting in continuous 4P films, (a) and 542
(c), as indicated by the close to zero Au signal. 543
During the recrystallisation both films (a) and (c) 544
aspire a thermodynamically stable island morphol- 545
ogy. However, the corresponding Au signals at 546
300 K are still significantly lower than for the films 547
initially grown at 300 K, (b) and (d). This indicates 548
a higher degree of wetting. Apparently, both kin- 549
etic and thermodynamic effects influence the 4P 550
film morphology. (2) The influence of a C pre-cov- 551
erage on the film morphology seems to be strongly 552
dependent on the growth temperature. At 93 K the 553
morphology of 4P films grown at 93 K is independ- 554
ent of a C pre-coverage. However, upon heat treat- 555
ment (regime II) an improved de-wetting is 556
observed in the case of a high C pre-coverage. This 557
is indicated by curve (c) being higher than curve (a) 558
within regime II. Different from that, films grown 559
at 300 K exhibit an opposite trend. Here, a C 560
pre-coverage causes an improved wetting, as indi- 561
cated by a smaller Au signal of (d) compared to (b) 562
at 300 K. This behaviour is most probably due to 563

564 an interplay between kinetic and thermodynamic
565 effects influencing the film morphology.

566 5. Summary

567 The possibility of tailoring the *p*-quaterphenyl
568 (4P) monolayer structure on a Au(111) surface
569 by applying different C pre-coverages has been
570 demonstrated, which in turn enables a tailoring
571 of the growth of several nm thick 4P films. Thin
572 4P films have been grown on various carbon pre-
573 covered Au(111) surfaces. The C coverages were
574 0.03, 0.15 and 0.5 ML, respectively. With increas-
575 ing C coverage a structural change of the 4P
576 monolayer was observed, revealing different
577 molecular packing modes compared to 4P grown
578 on C-free Au(111). Simultaneously, a significant
579 change of the 4P desorption kinetics was observed,
580 reflecting the different adsorption situations of 4P
581 molecules on variably C-covered Au(111) sur-
582 faces. A C pre-coverage as small as 0.03 ML pass-
583 ivates surface defects on the Au(111) surface,
584 which significantly increases the surface mobility
585 of 4P molecules in the monolayer. The 4P mono-
586 layer structure, however, is identical to that found
587 on a C-free Au(111) surface. On the 0.15 ML C/
588 Au(111) surface a coexistence of at least two dif-
589 ferent 4P monolayer structures has been identified.
590 The predominant structure exhibits a different
591 molecular packing (edge-on adsorbed molecules)
592 compared to previously found structures. Further-
593 more, the molecular orientation changes from ly-
594 ing to standing upright on a 0.5 ML C/Au(111)
595 surface. Combined XPS/TDS measurements re-
596 vealed a strong temperature dependence of the
597 morphology of thicker 4P films (up to 7 nm).

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